

<b>Notice of References Cited</b>	Application/Control No. 09/770,165	Applicant(s)/Patent Under Reexamination PAN ET AL.	
	Examiner Minh Dieu Nguyen	Art Unit 2137	Page 1 of 1

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	M	US-			

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	U	Translation of Merrien et al. WO 98/57474, 17 Dec 1998, pp. 1-18
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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